## Application/Control No. Applicant(s)/Patent Under Reexamination 10/617,048 LIEW ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ana L. Woodward -17-11 - -**U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,916,464 07-2005 424/59 Hansenne et al. Α US-В US-С US-D US-Ε US-F US-G US-Н USı US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Χ

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